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**PCI-6236**

## DEVICE SPECIFICATIONS

# NI 6236

M Series Data Acquisition: 16-Bit, 250 kS/s, 4 AI, 4 AO, 6 DI, 4 DO, Current Input, Voltage Output, Bank Isolation

The following specifications are typical at 25 °C, unless otherwise noted. For more information about the NI 6236, refer to the *NI 6236 User Manual* available at [ni.com/manuals](http://ni.com/manuals).

## Analog Input

Number of channels	4 differential current inputs
Channel type	Current input
ADC resolution	16 bits
DNL	No missing codes guaranteed
INL	Refer to <i>AI Absolute Accuracy</i> section
Sample rate	
Maximum	250 kS/s
Minimum	No minimum
Timing accuracy	50 ppm of sample rate
Timing resolution	50 ns
Input coupling	DC
Input range	±20 mA
Maximum working voltage for analog inputs	Refer to <i>Maximum Working Voltage</i> section
Input impedance under normal operating conditions (AI+ to AI-)	
Typical (25 °C)	92 $\Omega$ in parallel with 100 pF
Maximum (55 °C)	110 $\Omega$ in parallel with 100 pF
Input bias current	±100 pA
Crosstalk (at 100 kHz)	
Adjacent channels	-75 dB
Non-adjacent channels	-90 dB

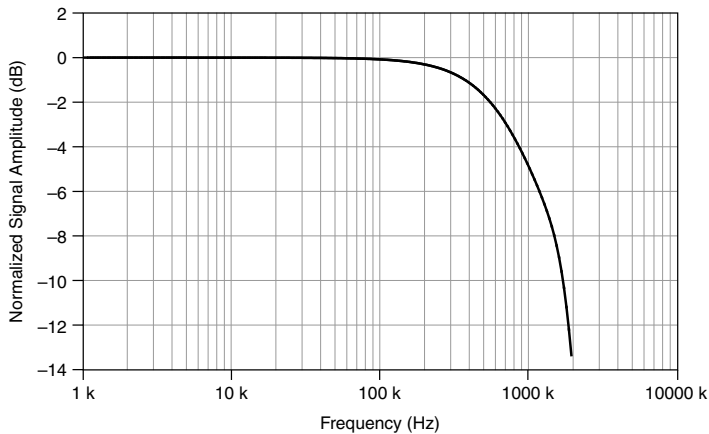
Small signal bandwidth (-3 dB)	700 kHz
Input FIFO size	4,095 samples
Scan list memory	4,095 entries
Data transfers	DMA (scatter-gather), interrupts, programmed I/O
Overvoltage protection (AI x+ or AI x- with respect to AI GND)	
Device on	±25 V for up to two AI pins
Device off	±15 V for up to two AI pins
Overvoltage protection (AI x+ to AI x-)	±20 V maximum
Overcurrent protection	±40 mA maximum <sup>1</sup>

## Settling Time for Multichannel Measurements

Accuracy, full-scale step, all ranges	
±90 ppm of step (±6 LSB)	4 µs convert interval
±30 ppm of step (±2 LSB)	5 µs convert interval
±15 ppm of step (±1 LSB)	7 µs convert interval

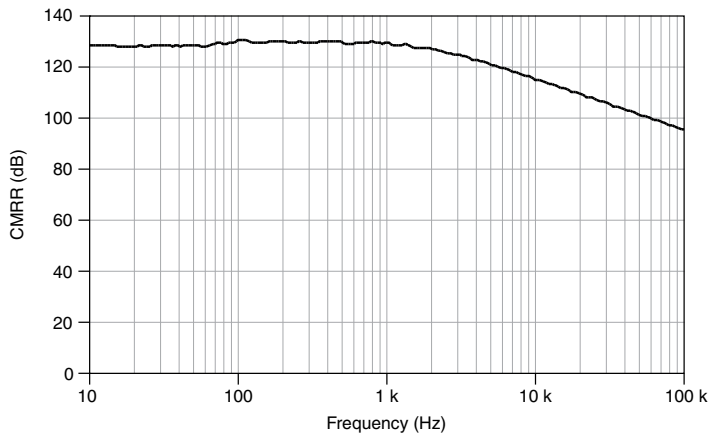
## Typical Performance Graphs

**Figure 1. AI Small Signal Bandwidth**



<sup>1</sup> Any voltage applied resulting in current flowing above 40 mA can damage the device permanently.

Figure 2. AI CMRR to Earth Ground



## AI Absolute Accuracy



**Note** Accuracies listed are valid for up to one year from the device external calibration.

Table 1. AI Absolute Accuracy

Nominal Range Positive Full Scale	Nominal Range Negative Full Scale	Residual Gain Error (ppm of Reading)	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	Random Noise, $\sigma$ ( $\mu$ Arms)	Absolute Accuracy at Full Scale ( $\mu$ A)	Sensitivity ( $\mu$ A)
0.02	-0.02	595	100	79	0.6	18.9	0.24



**Note** Sensitivity is the smallest current change that can be detected. It is a function of noise.

Gain tempco 35 ppm/°C

Reference tempco 5 ppm/°C

INL error 76 ppm of range

## AI Absolute Accuracy Equation

*AbsoluteAccuracy* = *Reading* · (*GainError*) + *Range* · (*OffsetError*) + *NoiseUncertainty*

*GainError* = *ResidualAIGainError* + *GainTempco* · (*TempChangeFromLastInternalCal*) + *ReferenceTempco* · (*TempChangeFromLastExternalCal*)

$$\text{OffsetError} = \text{ResidualAIOffsetError} + \text{OffsetTempco} \cdot (\text{TempChangeFromLastInternalCal}) + \text{INLError}$$

$$\text{NoiseUncertainty} = \frac{\text{Random Noise} \cdot 3}{\sqrt{100}} \text{ for a coverage factor of } 3 \sigma \text{ and averaging } 100 \text{ points.}$$

## AI Absolute Accuracy Example

Absolute accuracy at full scale on the analog input channels is determined using the following assumptions:

- TempChangeFromLastExternalCal = 10 °C
- TempChangeFromLastInternalCal = 1 °C
- number\_of\_readings = 100
- CoverageFactor = 3  $\sigma$

For example, on the 20 mA range, the absolute accuracy at full scale is as follows:

$$\text{GainError} = 595 \text{ ppm} + 35 \text{ ppm} \cdot 1 + 5 \text{ ppm} \cdot 10 = 680 \text{ ppm}$$

$$\text{OffsetError} = 100 \text{ ppm} + 79 \text{ ppm} \cdot 1 + 76 \text{ ppm} = 255 \text{ ppm}$$

$$\text{NoiseUncertainty} = \frac{.6 \mu\text{A} \cdot 3}{\sqrt{100}} = .18 \mu\text{A}$$

$$\text{AbsoluteAccuracy} = 20 \text{ mA} \cdot (\text{GainError}) + 20 \text{ mA} \cdot (\text{OffsetError}) + \text{NoiseUncertainty} = 18.9 \mu\text{A}$$

## Analog Output

Number of channels	4
Channel type	Voltage output
DAC resolution	16 bits
DNL	±1 LSB
Monotonicity	16 bit guaranteed
Maximum update rate	
1 channel	500 kS/s
2 channels	450 kS/s per channel
3 channels	425 kS/s per channel
4 channels	400 kS/s per channel
Timing accuracy	50 ppm of sample rate
Timing resolution	50 ns
Output range	±10 V
Output coupling	DC

Output impedance	0.4 $\Omega$
Output current drive	$\pm 5$ mA
Overdrive protection	$\pm 25$ V
Overdrive current	10 mA
Power-on state	$\pm 20$ mV
Power-on glitch	$\pm 2$ V for 2 ms
Power-off glitch <sup>2</sup>	$\pm 100$ mV for 350 ms
Output FIFO size	8,191 samples shared among channels used
Data transfers	DMA (scatter-gather), interrupts, programmed I/O
AO waveform modes	Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update
Settling time, full-scale step, 15 ppm (1 LSB)	6 $\mu$ s
Slew rate	15 V/ $\mu$ s
Glitch energy	
Magnitude	100 mV
Duration	3 $\mu$ s

## AO Absolute Accuracy

Absolute accuracy at full-scale numbers is valid immediately following internal calibration and assumes the device is operating within 10 °C of the last external calibration.



**Note** Accuracies listed are valid for up to one year from the device external calibration.

<sup>2</sup> When outputting 0 V on power down from the analog output channel.

**Table 2. AO Absolute Accuracy**

Nominal Range Positive Full Scale (A)	Nominal Range Negative Full Scale (A)	Residual Gain Error (ppm of Reading)	Gain Tempco (ppm/°C)	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	Absolute Accuracy at Full Scale (μA)
10	-10	90	10	40	5	3,230

Reference tempco 5 ppm/°C

INL error 128 ppm of range

## AO Absolute Accuracy Equation

$$AbsoluteAccuracy = OutputValue \cdot (GainError) + Range \cdot (OffsetError)$$

$$GainError = ResidualGainError + GainTempco \cdot (TempChangeFromLastInternalCal) + ReferenceTempco \cdot (TempChangeFromLastExternalCal)$$

$$OffsetError = ResidualOffsetError + AOffsetTempco \cdot (TempChangeFromLastInternalCal) + INLError$$

## Digital I/O/PFI

### Static Characteristics

Number of channels (10 total)

Number of input channels	6 (PFI <0..5>/P0.<0..5>)
Number of output channels	4 (PFI <6..9>/P1.<0..3>)
Ground reference	D GND
Direction control	Fixed, lines are unidirectional
Input voltage protection	±20 V on up to two pins <sup>3</sup>

### PFI/Port 0/Port 1 Functionality

PFI <0..5>/P0.<0..5>	Static digital input, timing input
PFI <6..9>/P1.<0..3>	Static digital output, timing output

<sup>3</sup> Stresses beyond those listed under *Input voltage protection* may cause permanent damage to the device.

Timing output sources	Many AI, AO, counter timing signals
Debounce filter settings	125 ns, 6.425 $\mu$ s, 2.56 ms, disable; high and low transitions; selectable per input

Digital Input Characteristics

Level	Minimum	Maximum
V <sub>IL</sub> input low voltage	0 V	0.8 V
V <sub>IH</sub> input high voltage	2 V	5.25 V
I <sub>IL</sub> input low current (V <sub>in</sub> = 0 V)	-	-10 $\mu$ A
I <sub>IH</sub> input high current (V <sub>in</sub> = 5 V)	-	10 $\mu$ A

Digital Output Characteristics

Table 3. Guaranteed Output Levels

Level	Voltage Level	Current Level
V <sub>OL</sub>	0.4 V	7 mA
V <sub>OL</sub>	0.6 V	10 mA
V <sub>OH</sub>	2.8 V	-24 mA
V <sub>OH</sub>	4.0 V	-6 mA

Maximum Operating Conditions

Level	Minimum	Maximum
I <sub>OL</sub> output low current P1.<0..3>	—	10 mA
I <sub>OH</sub> output high current P1.<0..3>	—	-24 mA

General-Purpose Counters/Timers

Number of counter/timers	2
Resolution	32 bits
Counter measurements	Edge counting, pulse, semi-period, period, two-edge separation



Position measurements	X1, X2, X4 quadrature encoding with Channel Z reloading; two-pulse encoding
Output applications	Pulse, pulse train with dynamic updates, frequency division, equivalent time sampling
Internal base clocks	80 MHz, 20 MHz, 0.1 MHz
External base clock frequency	0 MHz to 20 MHz
Base clock accuracy	50 ppm
Inputs	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down
Routing options for inputs	Any input PFI, RTSI, PXI_TRIG, PXI_STAR, many internal signals
FIFO	2 samples
Data transfers	Dedicated scatter-gather DMA controller for each counter/timer; interrupts; programmed I/O

## Isolation Effects

Maximum propagation delay through isolator	
Digital inputs	35 ns
Digital outputs	45 ns
Propagation delay skew between channels (inputs and outputs)	15 ns

## Frequency Generator

Number of channels	1
Base clocks	10 MHz, 100 kHz
Divisors	1 to 16
Base clock accuracy	50 ppm

Output can be available on any output PFI or RTSI terminal.

# Phase-Locked Loop (PLL)

Number of PLLs	1
Reference signal	PXI_STAR, PXI_CLK10, RTSI <0..7>
Output of PLL	80 MHz Timebase; other signals derived from 80 MHz Timebase including 20 MHz and 100 kHz Timebases

## External Digital Triggers

Source	Any PFI, RTSI, PXI_TRIG, PXI_STAR
Polarity	Software-selectable for most signals
Analog input function	Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Convert Clock, Sample Clock Timebase
Analog output function	Start Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase
Counter/timer function	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down

## Device-to-Device Trigger Bus

PCI	RTSI <0..7> <sup>4</sup>
PXI	PXI_TRIG <0..7>, PXI_STAR
Output selections	10 MHz Reference Clock, frequency generator output, many internal signals
Debounce filter settings	125 ns, 6.425 µs, 2.56 ms, disable; high and low transitions; selectable per input

## Bus Interface

PCI/PXI	3.3 V or 5 V signal environment
The PXI device can be installed in PXI slots or PXI Express hybrid slots.	
DMA channels	4, analog input, analog output, counter/timer 0, counter/timer 1

<sup>4</sup> In other sections of this document, RTSI refers to RTSI <0..7> for the PCI devices or PXI\_TRIG <0..7> for PXI devices.

# Power Requirements

Current draw from bus during no-load condition	
+5 V	0.5 A
+12 V	20 mA
Current draw from bus during AI and AO overvoltage condition	
+5 V	0.75 A
+12 V	20 mA

# Physical Characteristics

Dimensions	
PCI printed circuit board	9.7 cm × 15.5 cm (3.8 in. × 6.1 in.)
PXI printed circuit board	Standard 3U PXI
Weight	
PCI	110 g (3.8 oz)
PXI	150 g (5.2 oz)
I/O connector	37-pin D-SUB

# Calibration

Recommended warm-up time	15 minutes
Calibration interval	1 year

# Maximum Working Voltage

*Maximum working voltage* refers to the signal voltage plus the common-mode voltage.

Channel-to-earth ground <sup>5</sup>	
Continuous	≤30 Vrms/60 VDC Measurement Category I
Withstand	≤840 Vrms/1,200 VDC, verified by a 5 s dielectric withstand test

<sup>5</sup> In the figure,  $|V_a - V_e|$ ,  $|V_b - V_e|$ ,  $|V_c - V_e|$ , and  $|V_d - V_e|$ .

# Channel-to-bus<sup>6</sup>

Continuous	$\leq 30 \text{ Vrms}/60 \text{ VDC}$ Measurement Category I
Withstand	$\leq 1,400 \text{ Vrms}/1,950 \text{ VDC}$ , verified by a 5 s dielectric withstand test
AI channel-to-AI GND (in the following figure, $ V_a - V_d $ )	$\leq 11 \text{ V}$ , Measurement Category I
AO channel-to-AO GND (in the following figure, $ V_b - V_d $ )	$\leq 11 \text{ V}$ , Measurement Category I
Digital channel-to -D GND (in the following figure, $ V_c - V_d $ )	$\leq 5.25 \text{ V}$ , Measurement Category I

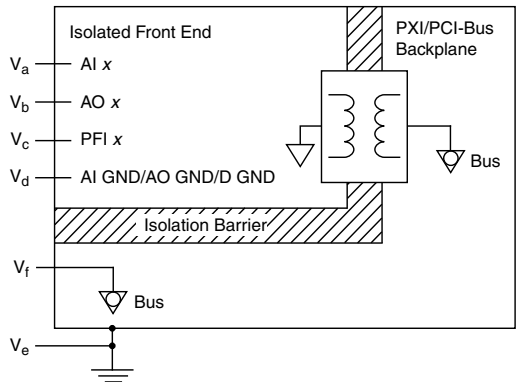
Measurement Category I is for measurements performed on circuits not directly connected to the electrical distribution system referred to as MAINS voltage. MAINS is a hazardous live electrical supply system that powers equipment. This category is for measurements of voltages from specially protected secondary circuits. Such voltage measurements include signal levels, special equipment, limited-energy parts of equipment, circuits powered by regulated low-voltage sources, and electronics.



**Caution** This device is rated for Measurement Category I and the voltage across the isolation barrier is limited to no greater than 30 Vrms/60 VDC/42.4 V<sub>pk</sub> continuous. These test and measurement circuits are not intended for direct connection to the MAINS building installations of Measurement Categories CAT II, CAT III, or CAT IV.

The following figure illustrates the maximum working voltage specifications.

**Figure 3. NI 6236 Maximum Working Voltage**



<sup>6</sup> In the figure,  $|V_a - V_f|$ ,  $|V_b - V_f|$ ,  $|V_c - V_f|$ , and  $|V_d - V_f|$ .

# Environmental

Operating environment	
Ambient temperature range	0 °C to 55 °C (Tested in accordance with IEC-60068-2-1 and IEC-60068-2-2.)
Relative humidity range	10% to 90%, noncondensing (Tested in accordance with IEC-60068-2-56.)
Storage environment	
Ambient temperature range	-40 °C to 70 °C (Tested in accordance with IEC-60068-2-1 and IEC-60068-2-2.)
Relative humidity range	5% to 95%, noncondensing (Tested in accordance with IEC-60068-2-56.)
Maximum altitude	2,000 m
Pollution Degree	2
Indoor use only.	

# Shock and Vibration (PXI Only)

Operational shock	30 g peak, half-sine, 11 ms pulse (Tested in accordance with IEC 60068-2-27. Test profile developed in accordance with MIL-PRF-28800F.)
Random vibration	
Operating	5 Hz to 500 Hz, 0.3 g <sub>rms</sub>
Nonoperating	5 Hz to 500 Hz, 2.4 g <sub>rms</sub> (Tested in accordance with IEC 60068-2-64. Nonoperating test profile exceeds the requirements of MIL-PRF-28800F, Class 3.)

# Safety

This product is designed to meet the requirements of the following electrical equipment safety standards for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1, CSA 61010-1



**Note** For UL and other safety certifications, refer to the product label or the [Online Product Certification](#) section.

# Electromagnetic Compatibility

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This product meets the requirements of the following EMC standards for electrical equipment for measurement, control, and laboratory use:

- EN 61326-1 (IEC 61326-1): Class A emissions; Basic immunity
- EN 55011 (CISPR 11): Group 1, Class A emissions
- EN 55022 (CISPR 22): Class A emissions
- EN 55024 (CISPR 24): Immunity
- AS/NZS CISPR 11: Group 1, Class A emissions
- AS/NZS CISPR 22: Class A emissions
- FCC 47 CFR Part 15B: Class A emissions
- ICES-001: Class A emissions



**Note** In the United States (per FCC 47 CFR), Class A equipment is intended for use in commercial, light-industrial, and heavy-industrial locations. In Europe, Canada, Australia and New Zealand (per CISPR 11) Class A equipment is intended for use only in heavy-industrial locations.



**Note** Group 1 equipment (per CISPR 11) is any industrial, scientific, or medical equipment that does not intentionally generate radio frequency energy for the treatment of material or inspection/analysis purposes.



**Note** For EMC declarations and certifications, and additional information, refer to the [Online Product Certification](#) section.

## CE Compliance

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This product meets the essential requirements of applicable European Directives, as follows:

- 2014/35/EU; Low-Voltage Directive (safety)
- 2014/30/EU; Electromagnetic Compatibility Directive (EMC)
- 2011/65/EU; Restriction of Hazardous Substances (RoHS)

## Online Product Certification

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Refer to the product Declaration of Conformity (DoC) for additional regulatory compliance information. To obtain product certifications and the DoC for this product, visit [ni.com/certification](https://ni.com/certification), search by model number or product line, and click the appropriate link in the Certification column.

# Environmental Management

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NI is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial to the environment and to NI customers.

For additional environmental information, refer to the *Minimize Our Environmental Impact* web page at [ni.com/environment](https://ni.com/environment). This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

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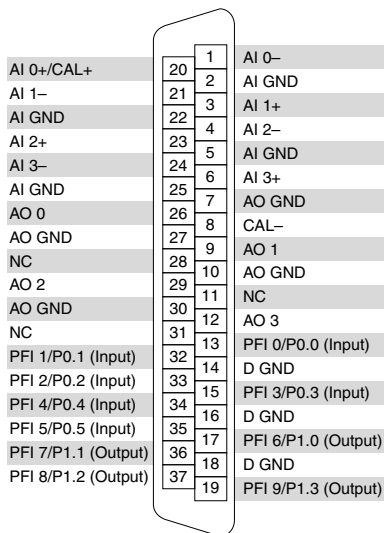
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# Device Pinout

**Figure 4. NI PCI/PXI-6236 Pinout**



NC = No Connect



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